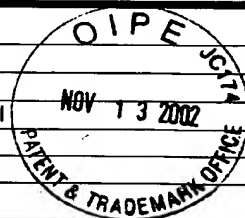


Substitute for form 1449B/PTO				Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Application Number	09/963,735
Date Submitted: November 13, 2002				Filing Date	09-27-2001
(use as many sheets as necessary)				First Named Inventor	Nobuo FUDANUKI
Sheet 1 of 1				Group Art Unit	2819
				Examiner Name	Unassigned
				Attorney Docket Number	016910-0476



U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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FOREIGN PATENT DOCUMENTS								
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		Office ³	Number ⁴	Kind Code ⁵ (if known)				
he	A1	JP	1-100942		Semiconductor Integrated Circuit	04-19-1989		X
he	A2	JP	61-253831		Standard Cell Semiconductor Apparatus	11-11-1986		X

OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ⁶
he	A3	"A Versatile VLSI Design System for Combining Gate Array and Standard Cell Circuits on the Same Chip," Robert Hornung, Martine Bonneau and Bernard Waymel, IEEE 1987 Custom Integrated Circuits Conference.	

Examiner Signature	Don	Date Considered	7/1/03
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¹ Unique citation designation number. ² See attached Kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.

⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

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08/963,735

INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

APPLICANT
FUDANUKI ET AL.

FILING DATE
12/23/1997

GROUP
2819

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1000
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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
h	4207556	6/1980	SUGIYAMA ET AL.	326	101	
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	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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